

# P-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$ Typ.	I <sub>D</sub> (A) <sup>d</sup>	Q <sub>g</sub> (TYP.)			
-60	0.050 at V <sub>GS</sub> = -10 V	-6.5	10.1 nC			
-60	0.060 at V <sub>GS</sub> = -4.5 V	-5.1	10.1110			

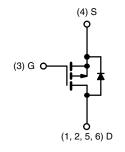
### **FEATURES**

- TrenchFET® power MOSFET
- 100 % R<sub>g</sub> and UIS tested



### **APPLICATIONS**

- Load switches
- DC/DC converter



P-Channel MOSFET

	_	TSOP Top Vi		_
1		1	6	
3 mm	П	2	5	Ш
	Ш	3	4	
	<b> -</b> -	<b>—</b> 2.85 m	nm —	

<b>ABSOLUTE MAXIMUM RATINGS (TA</b>	= 25 °C, unless other	wise noted)		
PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	V <sub>DS</sub>	-60	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v
	T <sub>C</sub> = 25 °C		-6.5	
Continuous Dusin Comment (T. 150 °C)	T <sub>C</sub> = 70 °C		-4.5	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	-3.8 <sup>a,b</sup>	
	T <sub>A</sub> = 70 °C		-3.1 <sup>a,b</sup>	
Pulsed Drain Current (t = 100 μs)	I <sub>DM</sub>	-20	Α	
Continuous Courses Dunie Dinda Coursest	T <sub>C</sub> = 25 °C	,	-3.5	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	l <sub>s</sub>	-1.7 <sup>a,b</sup>	
Avalanche Current		I <sub>AS</sub>	-15	
Single-Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	11.25	mJ
	T <sub>C</sub> = 25 °C		4.2	
Marian as Barray Discipation	T <sub>C</sub> = 70 °C		2.7	14/
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2 <sup>a,b</sup>	W
	T <sub>A</sub> = 70 °C		1.3 <sup>a,b</sup>	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C	

THERMAL RESISTANCE RATINGS							
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum Junction-to-Ambient a,c	t ≤ 10 s	R <sub>thJA</sub>	40	62.5	°C/W		
Maximum Junction-to-Foot	Steady State	R <sub>thJF</sub>	25	30	C/VV		

#### Notes

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Maximum under steady state conditions is 110  $^{\circ}\text{C/W}.$
- d. Based on  $T_C$  = 25 °C.

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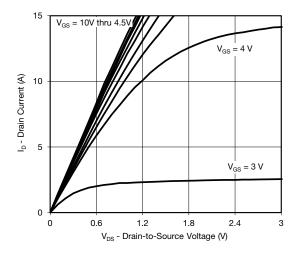
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static					l	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-60	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$			-6.7	-	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = -250  \mu A$	-	4.3	-	mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-	-0.5	-	-2V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA
Zara Cata Valta da Busin Correct		$V_{DS} = -60 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	-1	μА
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C	-	-	-5	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	-30	-	-	Α
Durin On the On Olate Business 3	Б	$V_{GS} = -10 \text{ V}, I_D = -3.5 \text{ A}$	-	0.050	-	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = -4.5 \text{ V}, I_D = -2.8 \text{ A}$	-	0.060	-	Ω
Forward Transconductance a	9 <sub>fs</sub>	$V_{DS} = -30 \text{ V}, I_D = -3.5 \text{ A}$	-	11	-	S
Dynamic <sup>b</sup>				I.		
Input Capacitance	C <sub>iss</sub>		-	832	-	pF
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	88	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	63	-	
Tabal Cata Obassa		$V_{DS} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -3.5 \text{ A}$	-	20	30	nC
Total Gate Charge			-	10.1	15.2	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = -30 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -3.5 \text{ A}$	-	3.3	-	
Gate-Drain Charge	Q <sub>gd</sub>		-	3.9	-	
Gate Resistance	$R_g$	f = 1 MHz	1.8	9	18	Ω
Turn-On Delay Time	t <sub>d(on)</sub>		-	8	16	
Rise Time	t <sub>r</sub>	$V_{DD} = -30 \text{ V}, R_1 = 10.7 \Omega$		6	12	1
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D\cong$ -2.8 A, $V_{GEN}=$ -10 V, $R_g=$ 1 $\Omega$	-	35	53	1
Fall Time	t <sub>f</sub>		-	16	24	
Turn-On Delay Time	t <sub>d(on)</sub>		-	40	60	ns
Rise Time	t <sub>r</sub>	$V_{DD}$ = -30 V, $R_L$ = 10.7 $\Omega$	-	28	42	
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D\cong$ -2.8 A, $V_{GEN}=$ -4.5 V, $R_g=$ 1 $\Omega$	-	31	47	
Fall Time	t <sub>f</sub>		-	15	23	
Drain-Source Body Diode Characterist	ics			l .	•	
Continous Source-Drain Diode Current	Is	T <sub>C</sub> = 25 °C		-	-3.5	
Pulse Diode Forward Current (t = 100 μs)	I <sub>SM</sub>		-	-	-20	A
Body Diode Voltage	V <sub>SD</sub>	$I_S = -2.8 \text{ A}, V_{GS} = 0 \text{ V}$	-	-0.85	-1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>		-	32	48	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$I_F = -2.8 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s,}$	-	45	68	nC
Reverse Recovery Fall Time $t_a$ $T_J = 25 ^{\circ}\text{C}$		-	24	-		
Reverse Recovery Rise Time	t <sub>b</sub>		-	8	-	ns

#### Notes

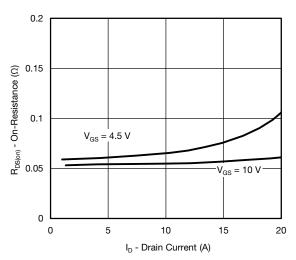
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

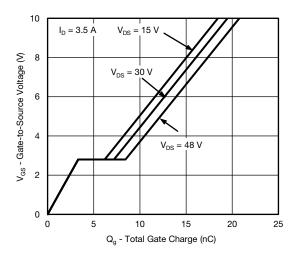




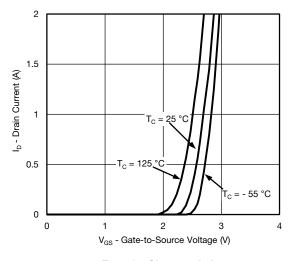




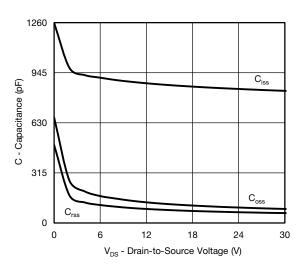
On-Resistance vs. Drain Current



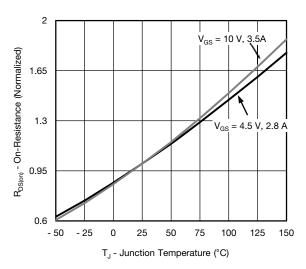
**Gate Charge** 



**Transfer Characteristics** 

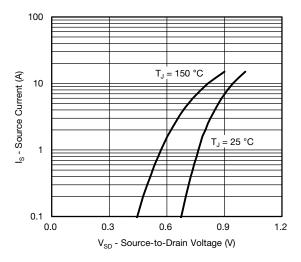


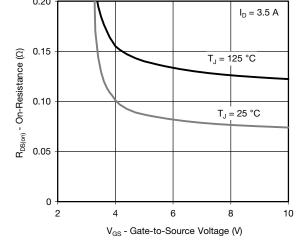
Capacitance



On-Resistance vs. Junction Temperature

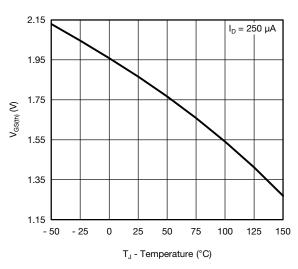


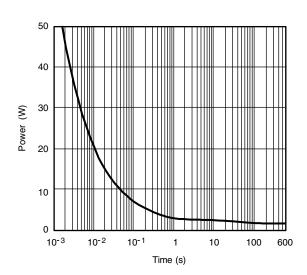




#### Source-Drain Diode Forward Voltage

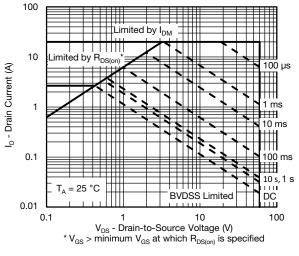
On-Resistance vs. Gate-to-Source Voltage





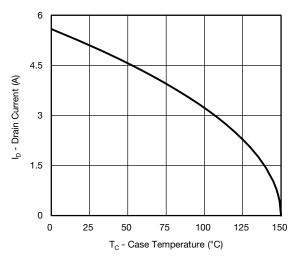
**Threshold Voltage** 

Single Pulse Power, Junction-to-Ambient

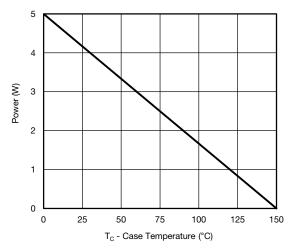


Safe Operating Area

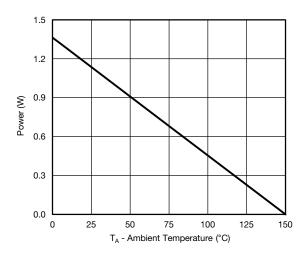




#### **Current Derating\***



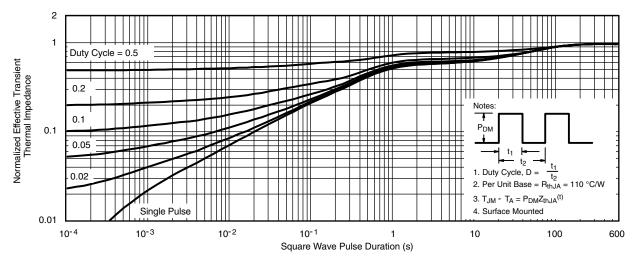




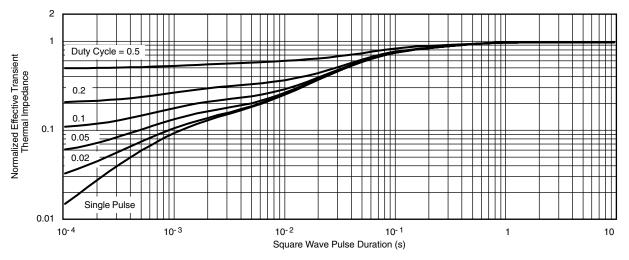
Power Derating, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J \text{ (max.)}} = 150 \,^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

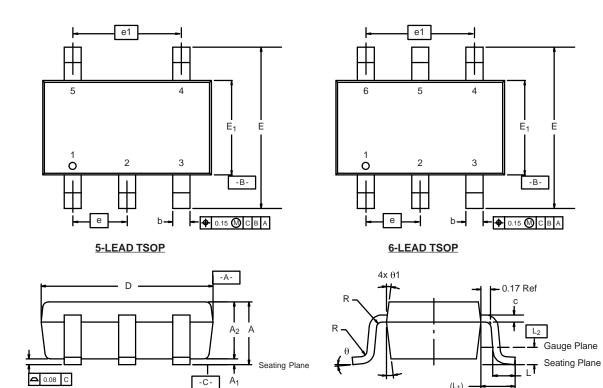


Normalized Thermal Transient Impedance, Junction-to-Foot



TSOP: 5/6-LEAD

**JEDEC Part Number: MO-193C** 

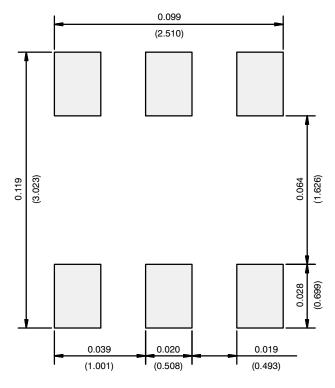


	MILLIMETERS			INCHES			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	0.91	-	1.10	0.036	-	0.043	
A <sub>1</sub>	0.01	-	0.10	0.0004	-	0.004	
A <sub>2</sub>	0.90	-	1.00	0.035	0.038	0.039	
b	0.30	0.32	0.45	0.012	0.013	0.018	
С	0.10	0.15	0.20	0.004	0.006	0.008	
D	2.95	3.05	3.10	0.116	0.120	0.122	
E	2.70	2.85	2.98	0.106	0.112	0.117	
E <sub>1</sub>	1.55	1.65	1.70	0.061	0.065	0.067	
е		0.95 BSC		0.0374 BSC			
e <sub>1</sub>	1.80	1.90	2.00	0.071 0.075 0.07			
L	0.32	-	0.50	0.012	-	0.020	
L <sub>1</sub>	0.60 Ref				0.024 Ref		
L <sub>2</sub>	0.25 BSC			0.010 BSC			
R	0.10	-	1	0.004	-		
θ	0°	4°	8°	0°	4°	8°	
$\theta_1$		7° Nom		7° Nom			
ECN: C-06593-Rev. I, 18-Dec-06 DWG: 5540							

4x θ1



# **RECOMMENDED MINIMUM PADS FOR TSOP-6**



Recommended Minimum Pads Dimensions in Inches/(mm)



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